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- Low r<sub>DS(on)</sub>...1 Ω Typ
- Output Short-Circuit Protection
- Avalanche Energy . . . 75 mJ
- Eight 350-mA DMOS Outputs
- 50-V Switching Capability
- Devices Are Cascadable
- Low Power Consumption

#### description

The TPIC6A595 is a monolithic, high-voltage, high-current power logic 8-bit shift register designed for use in systems that require relatively high load power. The device contains a built-in voltage clamp on the outputs for inductive transient protection. Power driver applications include relays, solenoids, and other medium-current or high-voltage loads. Each open-drain DMOS transistor features an independent chopping current-limiting circuit to prevent damage in the case of a short circuit.

This device contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit, D-type storage register. Data transfers through both the shift and storage registers on the rising edge of the shiftregister clock (SRCK) and the register clock (RCK), respectively. The storage register transfers data to the output buffer when shiftregister clear (SRCLR) is high. When SRCLR is low, the input shift register is cleared. When output

NE PACKAGE (TOP VIEW)										
DRAIN2   DRAIN3   SRCLR   PGND   PGND   RCK   SRCK   DRAIN4   DRAIN5	1 2 3 4 5 6 7 8 9 10	20 19 18 17 16 15 14 13 12 11	DRAIN1 DRAN0 SER IN V <sub>CC</sub> PGND PGND LGND SER OUT DRAIN7 DRAIN6							
	W PACI (TOP VI		E							
DRAIN2 [ DRAIN3 [ SRCLR [ PGND [ PGND [ PGND [ PGND [ RCK [ SRCK [ DRAIN4 [ DRAIN5 ]	<ul> <li>1</li> <li>2</li> <li>3</li> <li>4</li> <li>5</li> <li>6</li> <li>7</li> <li>8</li> <li>9</li> <li>10</li> <li>11</li> <li>12</li> </ul>	24 23 22 21 20 19 18 17 16 15 14 13	DRAIN1 DRAIN0 SER IN V <sub>CC</sub> PGND PGND PGND LGND SER OUT DRAIN7 DRAIN6							

enable ( $\overline{G}$ ) is held high, all data in the output buffers is held low and all drain outputs are off. When  $\overline{G}$  is held low, data from the storage register is transparent to the output buffers. The serial output (SER OUT) allows for cascading of the data from the shift register to additional devices.

Outputs are low-side, open-drain DMOS transistors with output ratings of 50 V and a 350-mA continuous sink current capability. When data in the output buffers is low, the DMOS-transistor outputs are off. When data is high, the DMOS-transistor outputs have sink current capability.

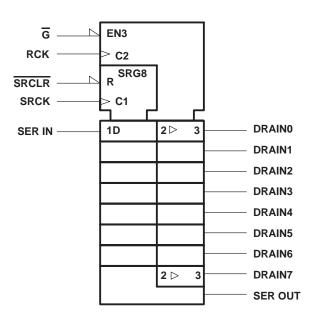
Separate power ground (PGND) and logic ground (LGND) terminals are provided to facilitate maximum system flexibility. All PGND terminals are internally connected, and each PGND terminal must be externally connected to the power system ground in order to minimize parasitic impedance. A single-point connection between LGND and PGND must be made externally in a manner that reduces crosstalk between the logic and load circuits.

The TPIC6A595 is offered in a thermally-enhanced dual-in-line (NE) package and a wide-body surface-mount (DW) package. The TPIC6A595 is characterized for operation over the operating case temperature range of  $-40^{\circ}$ C to  $125^{\circ}$ C.



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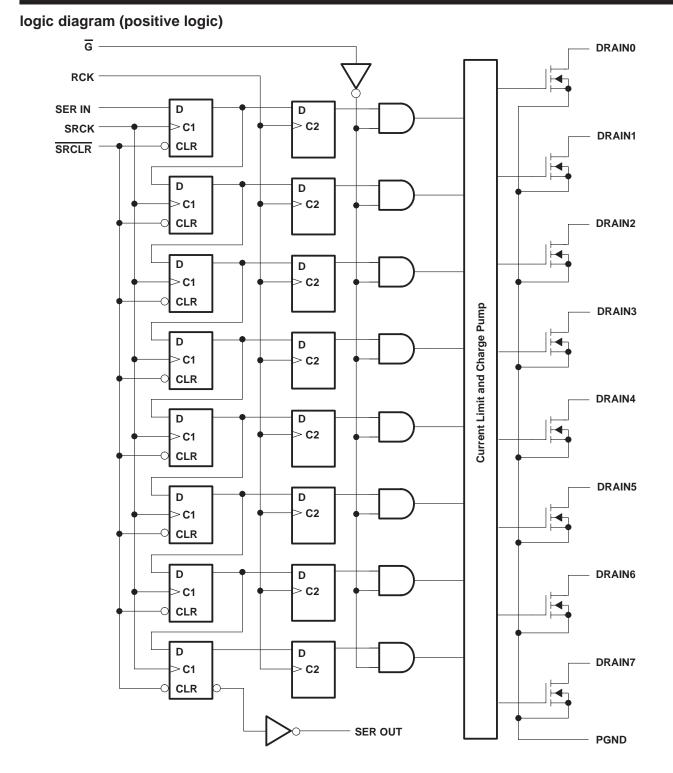
### logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



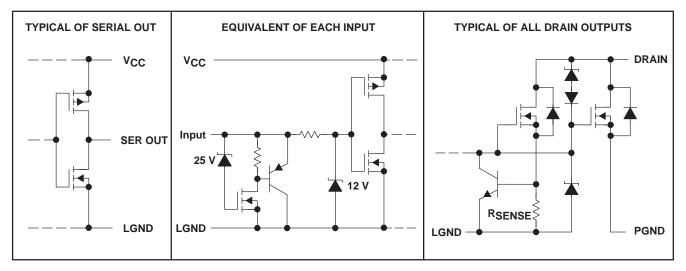
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### schematic of inputs and outputs



# absolute maximum ratings over recommended operating case temperature range (unless otherwise noted) $\!\!\!\!^\dagger$

Logic supply voltage, V <sub>CC</sub> (see Note 1)	
Logic input voltage range, V <sub>1</sub>	
Power DMOS drain-to-source voltage, V <sub>DS</sub> (see Note 2)	50 V
Continuous source-drain diode anode current	1 A
Pulsed source-drain diode anode current (see Note 3)	2 A
Pulsed drain current, each output, all outputs on, I <sub>Dn</sub> , T <sub>A</sub> = 25°C (see Note 3)	) 1.1 A
Continuous drain current, each output, all outputs on, IDn, TA = 25°C	350 mA
Peak drain current, single output, $T_A = 25^{\circ}C$ (see Note 3)	
Single-pulse avalanche energy, EAS (see Figure 6)	
Avalanche current, I <sub>AS</sub> (see Note 4)	600 mA
Continuous total dissipation	. See Dissipation Rating Table
Operating case temperature range, T <sub>C</sub>	−40°C to 125°C
Operating virtual junction temperature range, T <sub>J</sub>	−40°C to 150°C
Storage temperature range, T <sub>stg</sub>	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to LGND and PGND.

2. Each power DMOS source is internally connected to PGND.

3. Pulse duration  $\leq$  100 µs and duty cycle  $\leq$  2 %.

4. DRAIN supply voltage = 15 V, starting junction temperature ( $T_{JS}$ ) = 25°C, L = 210 mH,  $I_{AS}$  = 600 mA (see Figure 6).

#### **DISSIPATION RATING TABLE**

PACKAGE	T <sub>C</sub> ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T <sub>C</sub> = 25°C	T <sub>C</sub> = 125℃ POWER RATING		
DW	1750 mW	14 mW/°C	350 mW		
NE	2500 mW	20 mW/°C	500 mW		



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### recommended operating conditions

	MIN	MAX	UNIT
Logic supply voltage, V <sub>CC</sub>	4.5	5.5	V
High-level input voltage, VIH	0.85 V <sub>CC</sub>	VCC	V
Low-level input voltage, VIL	0	0.15 V <sub>CC</sub>	V
Pulsed drain output current, $T_C = 25^{\circ}C$ , $V_{CC} = 5 V$ (see Notes 3 and 5)	-1.8	0.6	А
Setup time, SER IN high before SRCK <sup>↑</sup> , t <sub>SU</sub> (see Figure 2)	10		ns
Hold time, SER IN high after SRCK <sup>↑</sup> , t <sub>h</sub> (see Figure 2)	10		ns
Pulse duration, t <sub>W</sub> (see Figure 2)	20		ns
Operating case temperature, T <sub>C</sub>	-40	125	°C

### electrical characteristics, $V_{CC} = 5 V$ , $T_C = 25^{\circ}C$ (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>(BR)</sub> DSX	Drain-to-source breakdown voltage	I <sub>D</sub> = 1 mA	50			V
V <sub>SD</sub>	Source-to-drain diode forward voltage	I <sub>F</sub> = 350 mA, See Note 3		0.8	1.1	V
Maria	High-level output voltage,	I <sub>OH</sub> = -20 μA	V <sub>CC</sub> -0.1	VCC		V
VOH	SER OUT	$I_{OH} = -4 \text{ mA}$	V <sub>CC</sub> -0.5	V <sub>CC</sub> -0.2		V
Max	Low-level output voltage,	I <sub>OL</sub> = 20 μA		0	0.1	V
VOL	SER OUT	$I_{OL} = 4 \text{ mA}$		0.2	0.5	V
IIН	High-level input current	$V_{I} = V_{CC}$			1	μΑ
Ι <sub>Ι</sub>	Low-level input current	$V_{I} = 0$			-1	μΑ
I <sub>O(chop)</sub>	Output current at which chopping starts	$T_{C} = 25^{\circ}C$ , See Note 5 and Figures 3 and 4	0.6	0.8	1.1	А
ICC	Logic supply current	$I_{O} = 0,$ $V_{I} = V_{CC} \text{ or } 0$		0.5	5	mA
ICC(FRQ)	Logic supply current at frequency			1.3		mA
l <sub>(nom)</sub>	Nominal current	$V_{DS(on)} = 0.5 V,$ $I_{(nom)} = I_D, T_C = 85^{\circ}C,$ $V_{CC} = 5 V,$ See Notes 5, 6, and 7		350		mA
	Ducin comparts off state	$V_{DS} = 40 \text{ V},   T_{C} = 25^{\circ}\text{C}$		0.1	1	
I <sub>D</sub>	Drain current, off-state	$V_{DS} = 40 \text{ V},   T_{C} = 125^{\circ}\text{C}$		0.2	5	μA
		$I_{\rm D} = 350 \text{ mA},  T_{\rm C} = 25^{\circ}\text{C}$		1	1.5	
<sup>r</sup> DS(on)	Static drain-source on-state resistance	$I_D = 350 \text{ mA}, T_C = 125^{\circ}C$ See Notes 5 and 6 and Figures 10 and 11		1.7	2.5	Ω
	resistance	$I_D = 350 \text{ mA}, T_C = 40^{\circ}\text{C}$				

NOTES: 3. Pulse duration  $\leq$  100  $\mu s$  and duty cycle  $\leq$  2%.

5. Technique should limit  $T_J - T_C$  to 10°C maximum.

6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

Nominal current is defined for a consistent comparison between devices from different sources. It is the current that produces a voltage drop of 0.5 V at T<sub>C</sub> = 85°C.



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### switching characteristics, V\_{CC} = 5 V, T\_C = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
<sup>t</sup> PHL	Propagation delay time, high-to-low-level output from $\overline{G}$			30	ns
<sup>t</sup> PLH	Propagation delay time, low-to-high-level output from $\overline{G}$	C <sub>L</sub> = 30 pF, I <sub>D</sub> = 350 mA,		125	ns
tr	Rise time, drain output	See Figures 1, 2, and 12		60	ns
t <sub>f</sub>	Fall time, drain output			30	ns
ta	Reverse-recovery-current rise time	I <sub>F</sub> = 350 mA, di/dt = 20 A/μs,		100	ns
t <sub>rr</sub>	Reverse-recovery time	See Notes 5 and 6 and Figure 5		300	ns

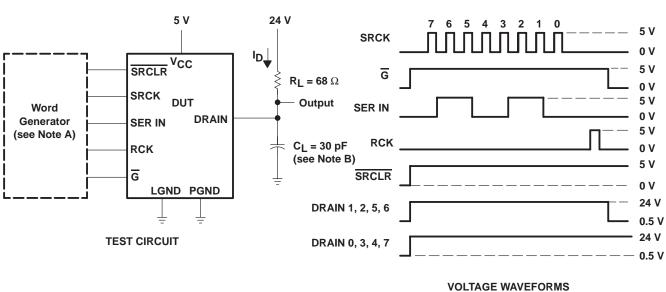
NOTES: 5. Technique should limit T<sub>J</sub> – T<sub>C</sub> to 10°C maximum.
 6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

#### thermal resistance

	PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
_	<b></b>	DW			10	
R <sub>0</sub> JC	Thermal resistance, junction-to-case	NE	All eight outputs with equal power		10	°C/W
		DW			50	0000
R <sub>θJA</sub>	Thermal resistance, junction-to-ambient	NE	All eight outputs with equal power		50	°C/W



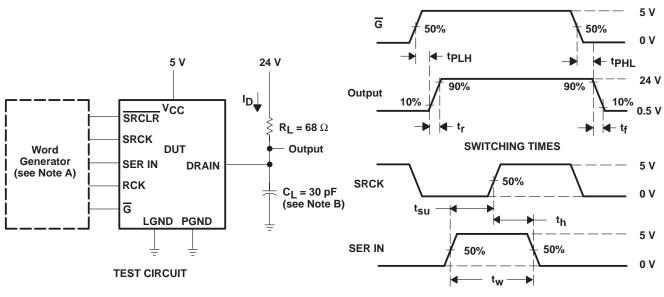
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#### PARAMETER MEASUREMENT INFORMATION

- NOTES: A. The word generator has the following characteristics:  $t_r \le 10$  ns,  $t_f \le 10$  ns,  $t_W = 300$  ns, pulsed repetition rate (PRR) = 5 kHz,  $Z_O = 50 \Omega$ .
  - B. CL includes probe and jig capacitance.

#### Figure 1. Resistive Load Operation



INPUT SETUP AND HOLD WAVEFORMS

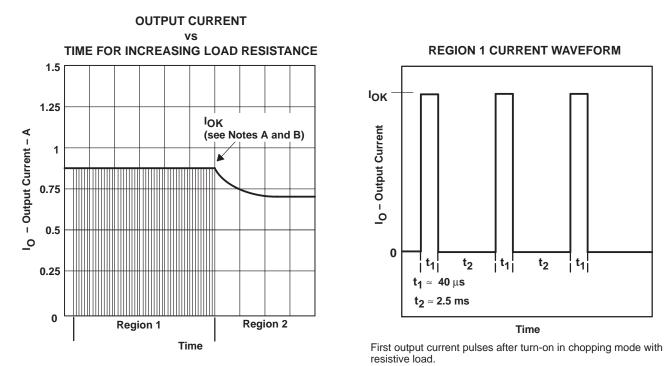
- NOTES: A. The word generator has the following characteristics:  $t_r \le 10$  ns,  $t_f \le 10$  ns,  $t_W = 300$  ns, pulsed repetition rate (PRR) = 5 kHz,  $Z_O = 50 \Omega$ .
  - B.  $C_{L}$  includes probe and jig capacitance.

Figure 2. Test Circuit, Switching Times, and Voltage Waveforms



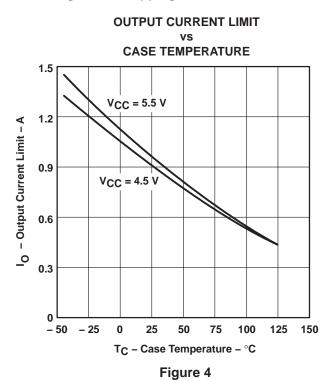
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#### PARAMETER MEASUREMENT INFORMATION



- NOTES: A. Figure 3 illustrates the output current characteristics of the device energizing a load having initially low, increasing resistance, e.g., an incandescent lamp. In region 1, chopping occurs and the peak current is limited to I<sub>OK</sub>. In region 2, output current is continuous. The same characteristics occur in reverse order when the device energizes a load having an initially high, decreasing resistance.
  - B. Region 1 duty cycle is approximately 2%.

#### **Figure 3. Chopping-Mode Characteristics**

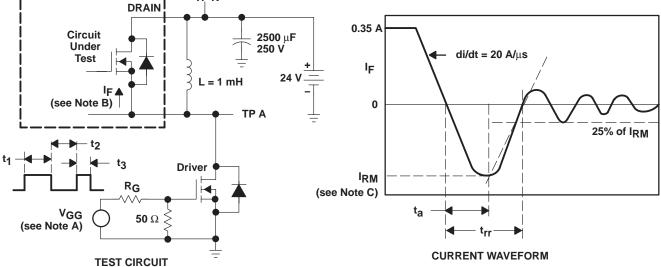




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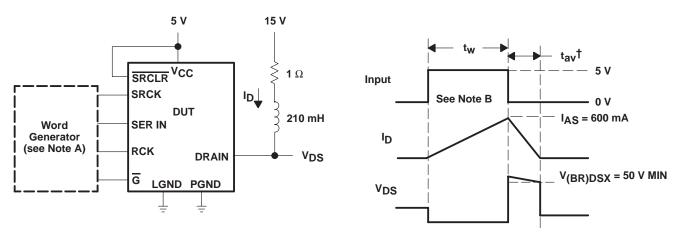


### PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The V<sub>GG</sub> amplitude and R<sub>G</sub> are adjusted for di/dt = 20 A/ $\mu$ s. A V<sub>GG</sub> double-pulse train is used to set I<sub>F</sub> = 0.35 A, where t<sub>1</sub> = 10  $\mu$ s, t<sub>2</sub> = 7  $\mu$ s, and t<sub>3</sub> = 3  $\mu$ s.
  - B. The DRAIN terminal under test is connected to the TP K test point. All other terminals are connected together and connected to the TP A test point.
  - C. I<sub>RM</sub> = maximum recovery current

#### Figure 5. Reverse-Recovery-Current Test Circuit and Waveforms of Source-Drain Diode



#### SINGLE-PULSE AVALANCHE ENERGY TEST CIRCUIT



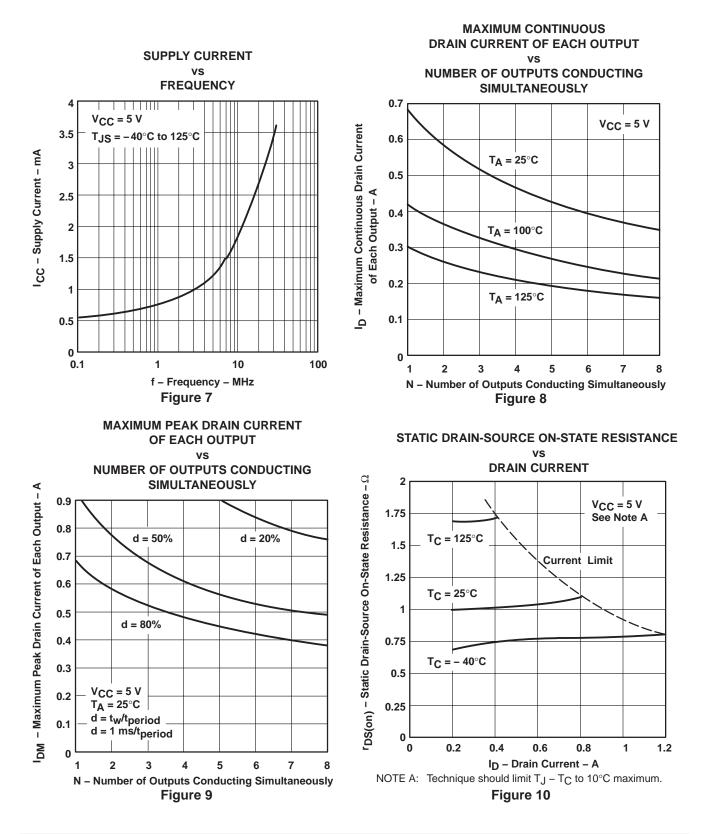
<sup>†</sup>Non JEDEC symbol for avalanche time.

NOTES: A. The word generator has the following characteristics:  $t_r \le 10$  ns,  $t_f \le 10$  ns,  $Z_O = 50 \Omega$ .

- B. Input pulse duration,  $t_{W}$ , is increased until peak current  $I_{AS} = 600$  mA.
  - Energy test level is defined as  $E_{AS} = (I_{AS} \times V_{(BR)DSX} \times t_{av})/2 = 75$  mJ.
    - Figure 6. Single-Pulse Avalanche Energy Test Circuit and Waveforms



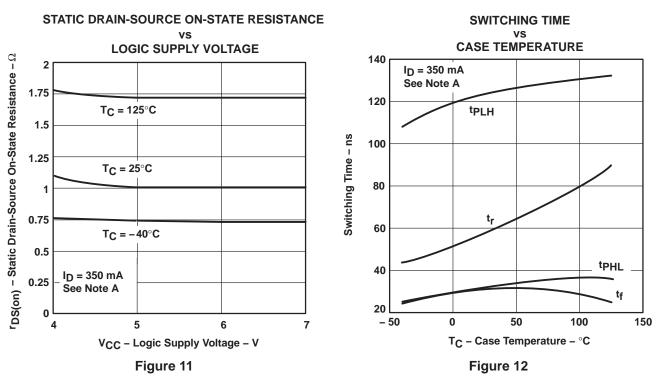
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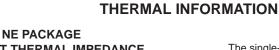
#### **TYPICAL CHARACTERISTICS**

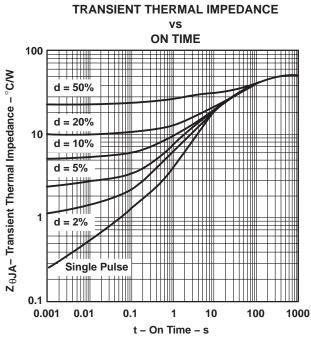


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NOTE A: Technique should limit  $T_J - T_C$  to 10°C maximum.





The single-pulse curve represents measured data. The curves for various pulse durations are based on the following equation:

$$Z_{\theta \mathsf{J} \mathsf{A}} = \left| \frac{t_{\mathsf{w}}}{t_{\mathsf{c}}} \right| R_{\theta \mathsf{J} \mathsf{A}} + \left| 1 - \frac{t_{\mathsf{w}}}{t_{\mathsf{c}}} \right| Z_{\theta}(t_{\mathsf{w}} + t_{\mathsf{c}})$$

Where:

 $\mathsf{Z}_{\theta}(t_{w})$  = the single-pulse thermal impedance for t =  $t_{w}$  seconds

+  $Z_{\theta}(t_w) - Z_{\theta}(t_c)$ 

- $\mathsf{Z}_{\theta}(\mathsf{t}_c)$  = the single-pulse thermal impedance for t = t\_c seconds
- $\begin{array}{l} {\sf Z}_{\theta}(t_{w}\,+\,t_{c})\,=\, the \, single-pulse \, thermal \, impedance \\ for \, t=\, t_{w}\,+\, t_{c} \, seconds \end{array}$

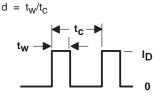


Figure 13



### TYPICAL CHARACTERISTICS

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### **Revision History**

DATE	REV	PAGE	SECTION	DESCRIPTION
5/18/05	В	7	Figure 1	Changed SRCLR timing diagram and changed title on Drain timing diagrams
1/1/95	А		—	—
4/1/93	*			Original reversion

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.





### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
TPIC6A595DW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TPIC6A595	Samples
TPIC6A595DWG4	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TPIC6A595	Samples
TPIC6A595DWR	ACTIVE	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TPIC6A595	Samples
TPIC6A595DWRG4	ACTIVE	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TPIC6A595	Samples
TPIC6A595NE	ACTIVE	PDIP	NE	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-40 to 125	TPIC6A595NE	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



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# PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



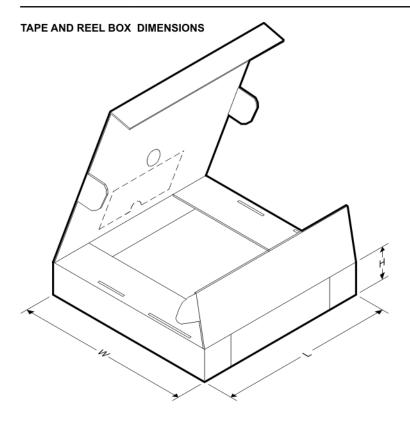
*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPIC6A595DWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
TPIC6A595DWRG4	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

5-Jul-2019



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPIC6A595DWR	SOIC	DW	24	2000	350.0	350.0	43.0
TPIC6A595DWRG4	SOIC	DW	24	2000	350.0	350.0	43.0

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



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